Application/Control No. Applicant(s)/Patent Under Reexamination 10/605.944 BOUDON ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 ERIC C. WAI 2195 U.S. PATENT DOCUMENTS

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-6,246,257	06-2001	Kawahara, Hiroyuki	326/38		
	В	US-					
	С	US-					
	D	US-					
	E	US-					
	F	US-					
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